

Notice of References Cited	Application/Control No. 10/662,394		Applicant(s)/Patent Under Reexamination AKIYAMA ET AL.	
	Examiner Danny Wai Lun Leung		Art Unit 2613	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,154,273 A	11-2000	Suzuki, Yasuo	356/73.1
*	C	US-6,885,820 B2	04-2005	Eder et al.	398/26
*	D	US-6,859,268 B2	02-2005	Chou et al.	356/73.1
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	M	US-			

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.